Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
‖‖‖‖‖‖‖‖‖‖‖	10/751,049	LEE, JAE HUN
	Examiner	**Art Unit**
	Lee Y Quach	2875

ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
362	507	362	505	506					
INTERNATIONAL CLASSIFICATION									
B 6 0 Q	1/04								
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	/								

(Assistant Examiner) (Date)		**Total Claims Allowed: 3**	
(signature) 10/27/05 (Legal Instruments Examiner) (Date)	Y. MY QUACH-LEE 10/26/05 **PRIMARY EXAMINER** (Primary Examiner) (Date)	O.G. Print Claim(s) 1	O.G. Print Fig. 1

| ☐ Claims renumbered in the same order as presented by applicant | ☐ CPA | ☐ T.D. | ☐ R.1.47 |

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		91		121		151		181
2	2		32		62		92		122		152		182
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	30		60		90		120		150		180		210

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Part of Paper No. 102605